

**Notice of References Cited**

Application/Control No.

10/536,945

Applicant(s)/Patent Under  
Reexamination  
ISHIDA ET AL.

Examiner

BUNJOB JAROENCHONWANIT

Art Unit

2466

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0065921 A1	05-2002	Davidson et al.	709/227
*	B	US-2002/0083191 A1	06-2002	Ryuutou et al.	709/237
*	C	US-6,523,696 B1	02-2003	Saito et al.	709/223
*	D	US-2004/0052257 A1	03-2004	Abdo et al.	370/392
*	E	US-2004/0240468 A1	12-2004	Chin et al.	370/466
*	F	US-6,957,275 B1	10-2005	Sekiguchi, Kiyonori	709/245
*	G	US-2006/0259639 A1	11-2006	Aken et al.	709/245
*	H	US-7,600,025 B2	10-2009	Lewin et al.	709/226
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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